## Notice of References Cited Application/Control No. 10/577,509 Applicant(s)/Patent Under Reexamination SCHERRER ET AL. Examiner Lan Nguyen Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,560,688	10-1996	Schappler et al.	303/3
*	В	US-6,238,018	05-2001	Sugimoto et al.	303/146
	O	US-			
	D	US-			
	Е	US-			
	F	US-			
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	Ι	US-		ji	
	_	US-			
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	K	US-			
	L	US-			
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## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## NON-PATENT DOCUMENTS

*		Indiada ao amin'ny fivondronan'i Paris Data Database Faltina ao Valore ao Database Danas
	U	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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